



ELECTRONICS, INC.  
 44 FARRAND STREET  
 BLOOMFIELD, NJ 07003  
 (973) 748-5089  
<http://www.nteinc.com>

## NTE30051 & NTE30052 Infrared Phototransistor

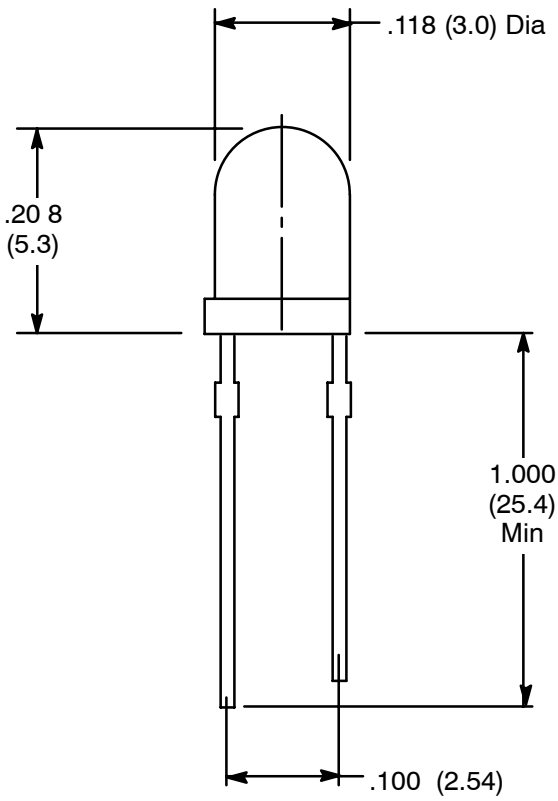
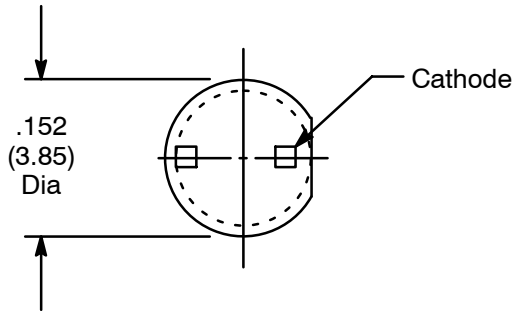
**Absolute Maximum Ratings:** ( $T_A = +25^\circ\text{C}$  unless otherwise specified)

Sensitive Area, AA .....	0.19mm
Power Dissipation, $P_D$ .....	150mW
Collector–Emitter Voltage, $V_{CEO}$ .....	30V
Emitter–Collector Voltage, $V_{ECO}$ .....	5V
Operating Temperature Range, $T_{opr}$ .....	$-25^\circ$ to $+85^\circ\text{C}$
Storage Temperature Range, $T_{stg}$ .....	$-40^\circ$ to $+100^\circ\text{C}$
Lead Temperature (During Soldering, .062 (1.6mm) from case bottom, 5sec max), $T_L$	
NTE30051 .....	+240°C
NTE30052 .....	+260°C

**Electrical Characteristics:** ( $T_A = +25^\circ\text{C}$  unless otherwise specified)

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
Angle of Half Sensitive NTE30051	2θ1/2	$I_C = 1\text{mA}, E_e = 0\text{mW}/\text{cm}^2$	–	20	–	Degree
NTE30052			–	38	–	Degree
Collector–Emitter Voltage	$V_{CEO}$	$I_C = 1\text{mA}, E_e = 0\text{mW}/\text{cm}^2$	30	–	–	V
Emitter–Collector Voltage	$V_{ECO}$	$I_C = 100\mu\text{A}, E_e = 0\text{mW}/\text{cm}^2$	–	5	–	V
Collector–Emitter Saturation Voltage	$V_{CES}$	$I_C = 0.5\text{mA}, I_b = 100\mu\text{A}$	–	–	0.4	V
Collector Current (Saturation) NTE30051	$I_C$	$V_{CE} = 5\text{V}, E_e = 0.5\text{mW}/\text{cm}^2$	0.2	1.5	–	mA
NTE30052			0.8	3.0	12	mA
Collector Dark Current	$I_{CEO}$	$V_{CE} = 20\text{V}, E_e = 0\text{mW}/\text{cm}^2$	–	–	100	nA
Rise Time	$t_r$	$V_{CE} = 5\text{V}, I_C = 1\text{mA}, R_L = 1000\Omega$	–	15	–	μs
Fall Time	$t_f$	$V_{CE} = 5\text{V}, I_C = 1\text{mA}, R_L = 1000\Omega$	–	15	–	μs
Peak Wavelength	$\lambda_p$		–	900	–	nm
Sensitivity Wavelength	$\lambda$		500	–	1100	nm

**NTE30051**



**NTE30052**

